

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/658,637	SEIP, WILLIAM FRANCIS	
Examiner	Art Unit	
Nathan A. Bowers	1744	

Nathan A. Bowers

SEAR	CHED	
Subclass	Date	Examiner
801	11/16/2006	NAB
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	Subclass 801	Subclass Date  801 11/16/2006

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Inventor name search	11/16/2006	NAB
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT) - see search history printout	11/16/2006	NAB
252/188.28 ; 435/809,801,41,325,373,404,284.1,80 7,299 - text search only	11/16/2006	NAB
422/211,58,86,212,236,238,239,219,2 87 ; 48/192 ; 423/219 ; 55/414,444 - text search only	11/16/2006	NAB